



BSI Standards Publication

Semiconductor devices

Part 5-9: Optoelectronic devices — Light emitting diodes —
Test method of the internal quantum efficiency based on
the temperature-dependent electroluminescence

National foreword

This British Standard is the UK implementation of IEC 60747-5-9:2019.

The UK participation in its preparation was entrusted to Technical Committee EPL/47, Semiconductors.

A list of organizations represented on this committee can be obtained on request to its secretary.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

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